

Status and Outlook of Si-Strip-Sensors from Infineon Technologies AG

Hacker Johannes, 2017-12-11

11th International “Hiroshima” Symposium on the
Development and Application of Semiconductor
Tracking Detectors (HSTD11)



CERN LHC ATLAS + CMS Phase-II Upgrades

Long Shutdown 3 (LS3) scheduled for 2024-2025

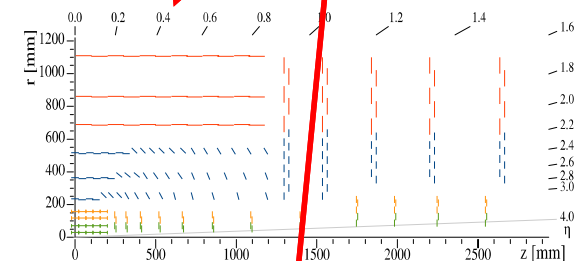
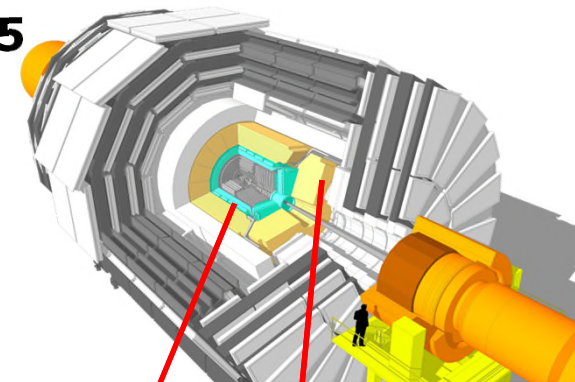
- › Accelerator upgrade to High-Luminosity-(HL)-LHC
- › Upgrade of experiments necessary
 - Existing systems reach end of life (radiation damage)
 - Increase in luminosity at HL-LHC: $300 \rightarrow 3000 \text{ fb}^{-1}$

Phase-II Upgrade of ATLAS + CMS:

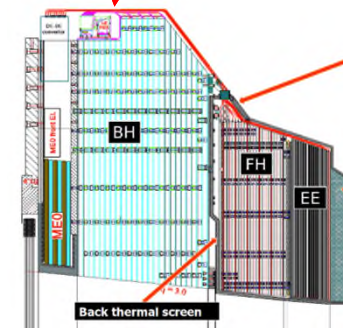
- › Complete exchange of Outer Trackers
 - $\sim 200 \text{ m}^2$ Si Sensors/experiment needed
- › CMS: New Highly Granularity Calorimeter (HGCaI)
 - 600 m^2 Si Sensors (8 inch)

Both experiments need industrial partners

- › Industrial production necessary due to large quantities
- › → Cooperation HEPHY/Vienna & Infineon Technologies



Layout of Ph-II CMS tracker
Layout of CMS-HGCalorimeter



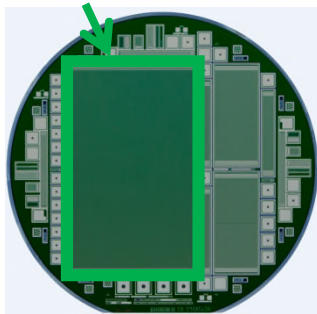
Collaboration HEPHY-Infineon Technologies

- › HEPHY Vienna and Infineon Technologies cooperate since 2009 on the development of Si-sensors for HL-LHC-experiments
- › Responsibilities
 - HEPHY: Layout-design, characterization, test-beams, irradiations, device-simulations
 - Infineon: Process-engineering, processing, establish series testing at Infineon
- › Focus
 - Single sided planar AC-coupled n-in-p Si-strip sensors for Trackers of ATLAS + CMS Phase II Upgrades in 6"-technology
Active thicknesses: 300/320 μm and 240 μm
 - Single sided planar DC-coupled n-in-p Si-pad sensors for HGC of CMS Phase II Upgrade in 8"-technology, 300, 200, 120 μm
- › Following measurements were done by HEPHY/Vienna if not stated otherwise

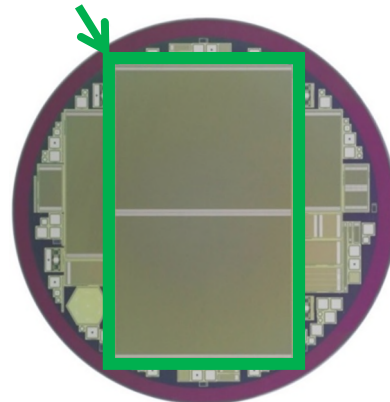
Achievements Overview

Wafer size	Polarity	Layout	Chipsize [cm ²] main sensor	Thickness [μm] physical ≈ active
6"	p-in-n FZ	AC-Strip	10 x 7	200, 300
8"	n-in-p FZ	AC-Strip	15 x 10	200, 300
8"	n-in-p FZ	DC-Pad	18 x 16 hexagonal	140, 200, 300, 350
6"	n-in-p FZ	AC-Strip	5 x 10	240, 500

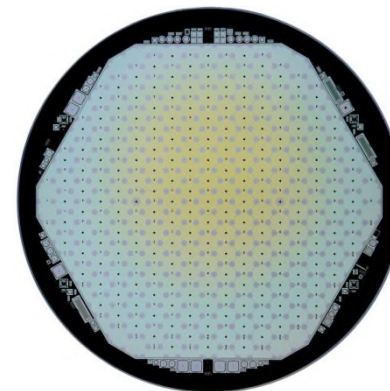
2012



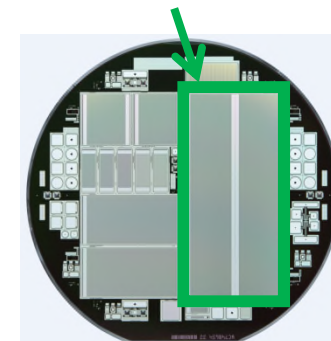
2015



2016

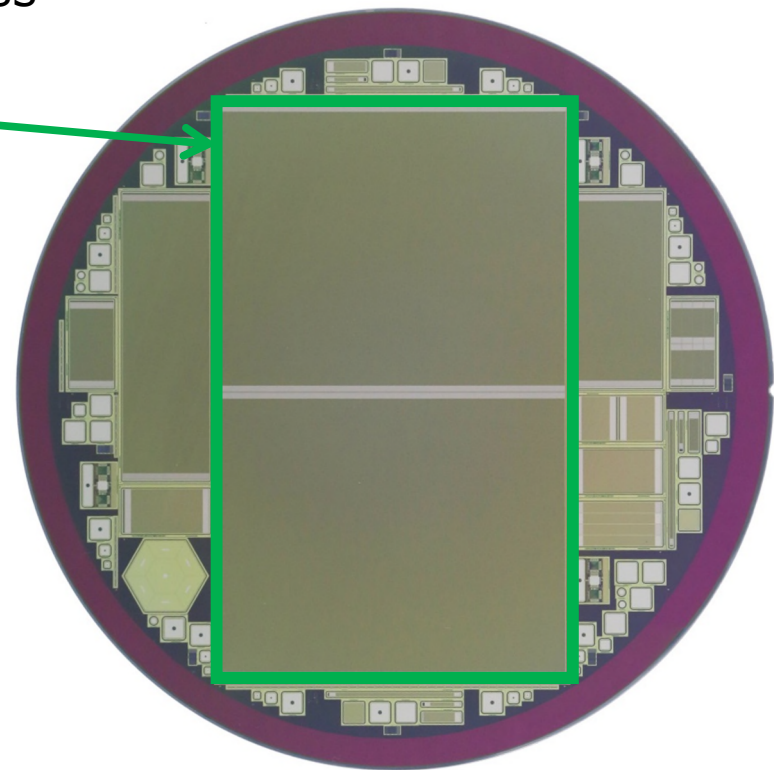


2017



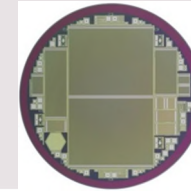
World's first AC-coupled Sensors on 8" Wafers

- › Wafer for CMS-Phase II-Upgrade-Strip-Tracker
 - Wafer diameter (8" wafer): 200 mm
 - Resistivity 3..8 kΩcm, n-on-p float zone, orientation <100>
 - 200 μm and 300 μm physical thickness
- › Main Sensor
 - Size: 94.183 x 153.4 mm²
 - Strips: 2032, Strip length: 75.6 mm
 - Strip Pitch: 90 μm, P-stop: Atoll
- › Split groups for runs:
 - p-stop / p-spray, Dose, Profile
 - Different R_poly doping

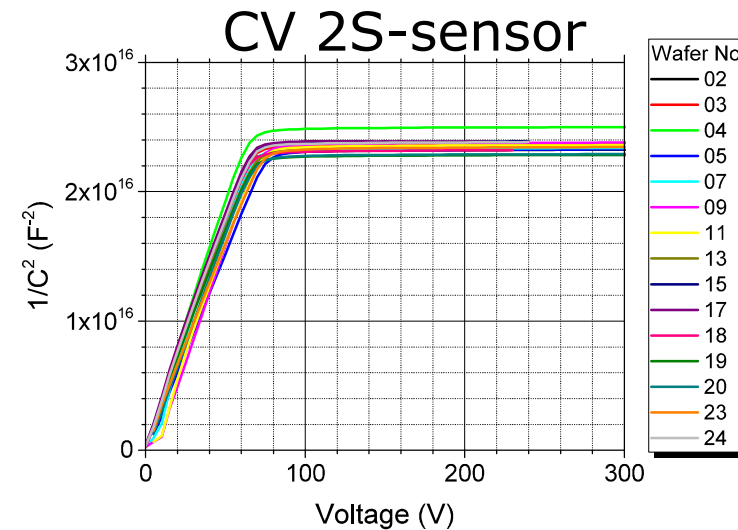
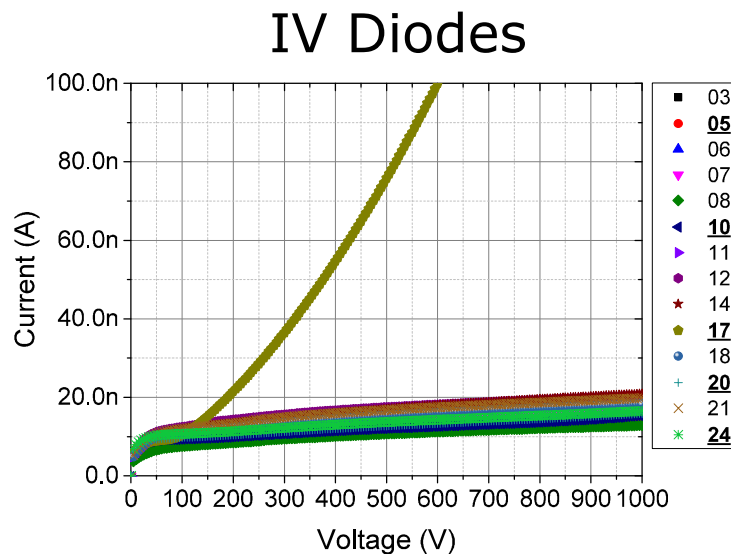
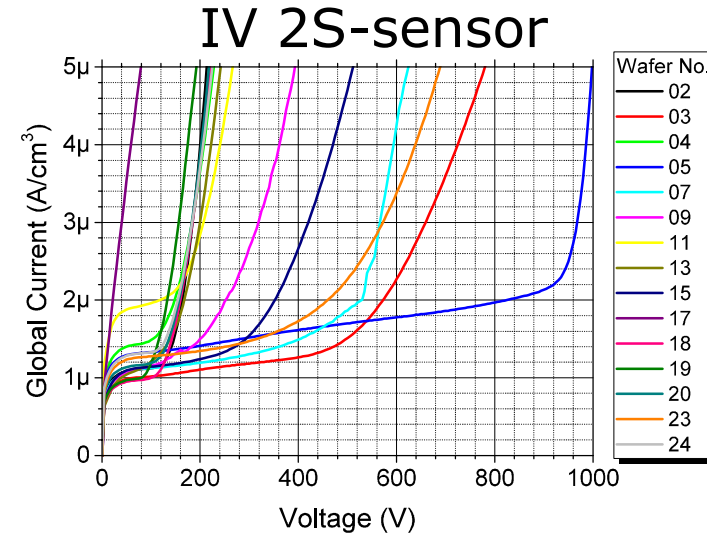


AC-coupled Strip-Sensors on 8" Wafers

Global parameters IV and CV

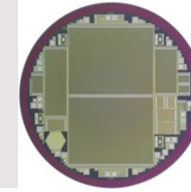


- › Sensor-size: 15 cm x 9 cm
- › Full depletion voltage of ~ 75 V
- › Sensor-HV-stability to be improved
- › Diodes are HV-stable

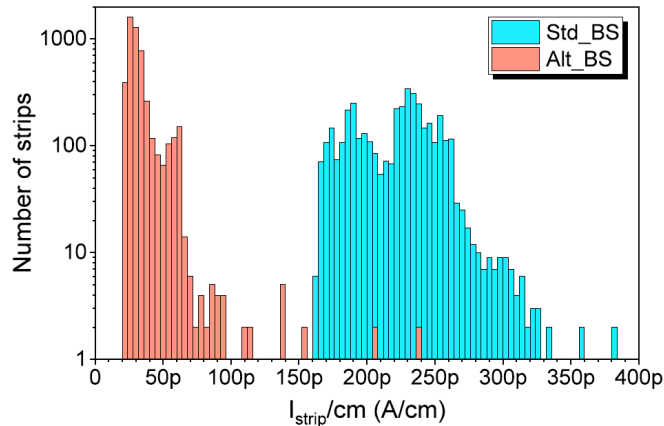


AC-coupled Strip-Sensors on 8" Wafers

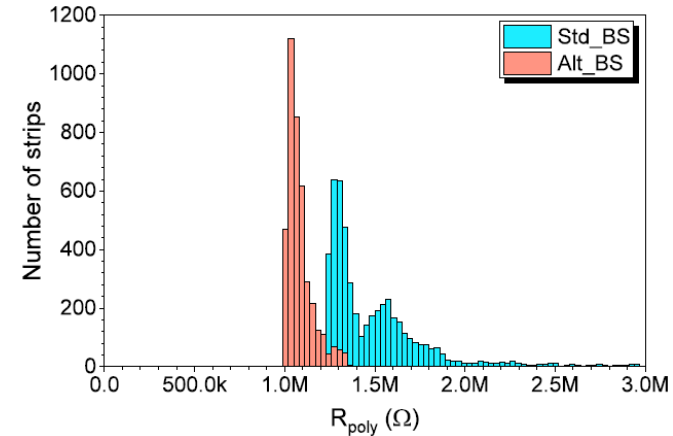
Strip parameters of 9 2S_long sensors



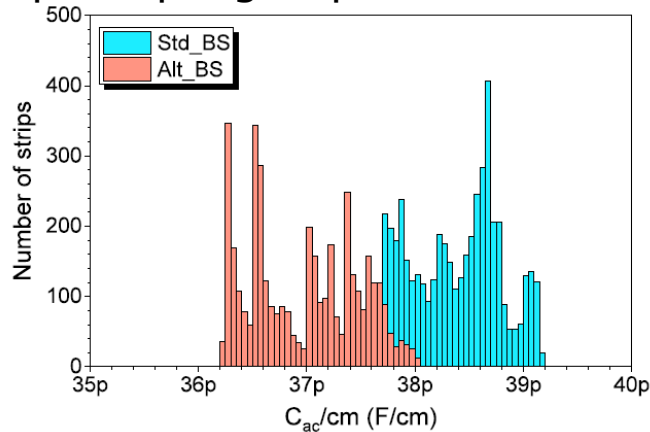
› Single Strip Current



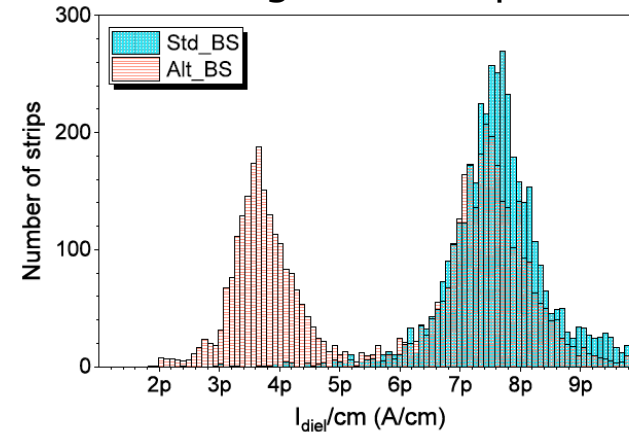
› Polysilicon Resistance



› Strip Coupling Capacitance

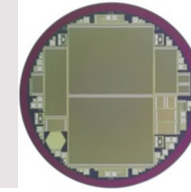


› Current Through the Strip Dielectric

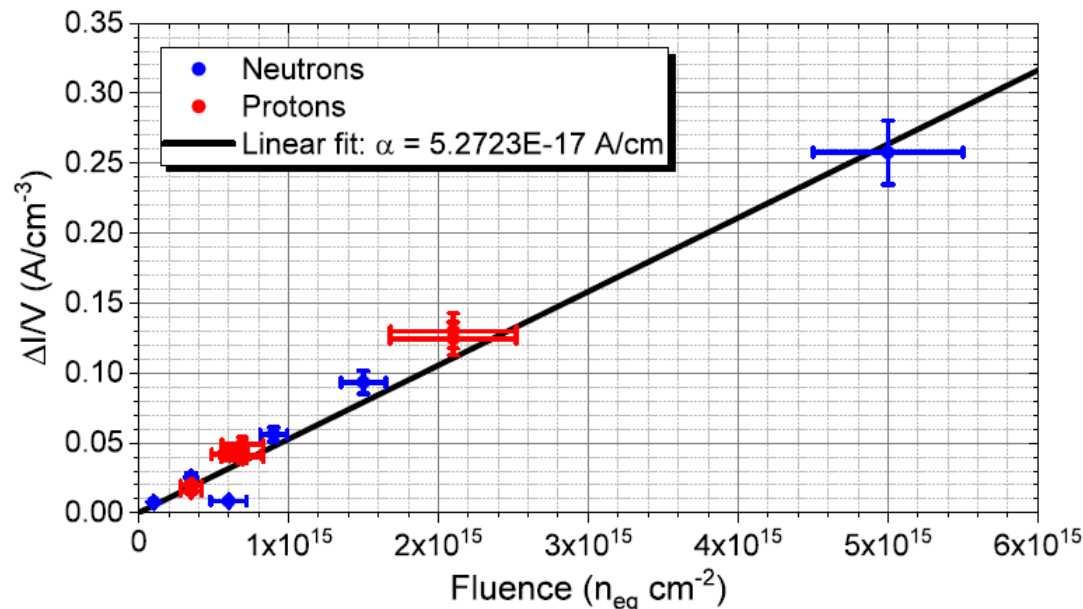


› All strip-parameters of target-process „Std_BS“ are in spec.

AC-coupled Strip-Sensors on 8" Wafers Irradiation



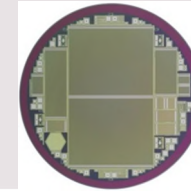
- › Proton + Neutron irradiations of sensors and diodes were performed
- › Difference in current before and after irradiation divided by the active volume after annealing of 10 min at 60 °C vs the 1 MeV neutron equivalent fluence, measured at -20 °C, scaled to 20 °C



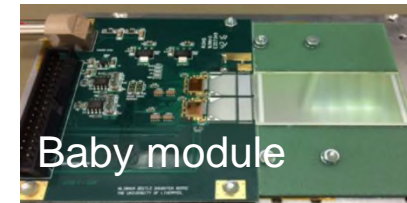
- › α -value: $(5.27 \pm 0.23) \cdot 10^{-17}$ A/cm in line with theoretical expectations
- › Radiation hardness of sensors of Infineon validated

AC-coupled Strip-Sensors on 8" Wafers

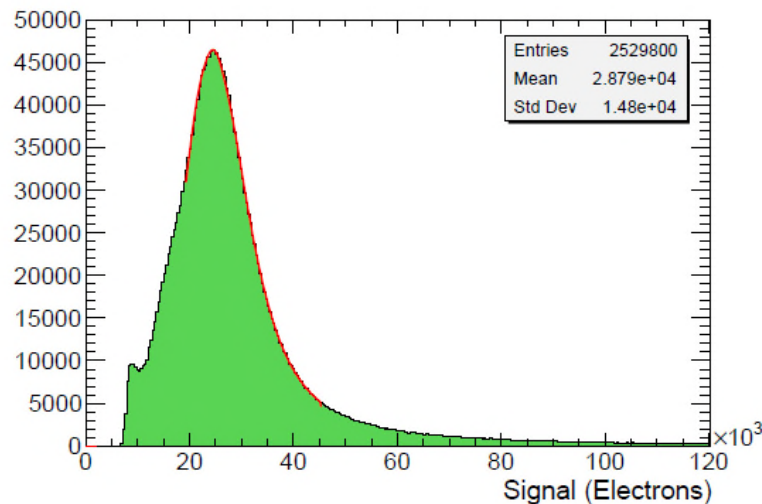
Beam-Test: Most Probable Value



- › Electron beam test conducted at DESY using a ALiBaVa Readout System

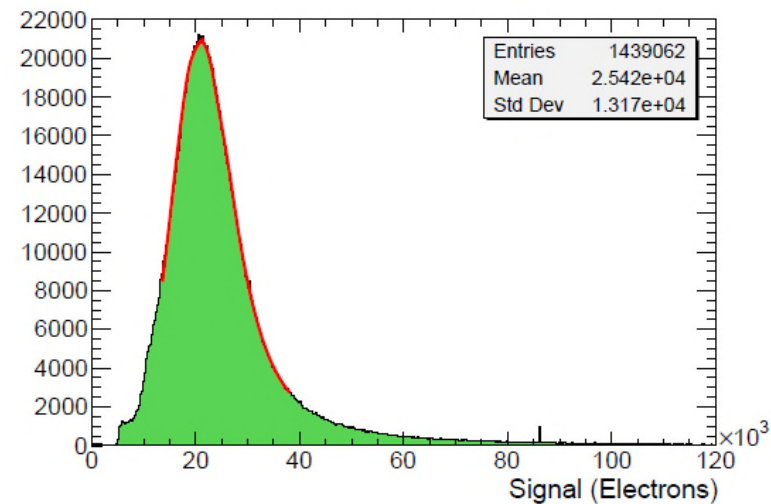


Unirradiated sensor



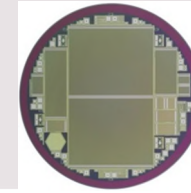
$$\text{MPV}_{\text{Baby}} = 23660 \text{ e}^-$$

Irradiated sensor with neutrons $3.5 \cdot 10^{14} \text{ n}_{\text{eq}} \text{ cm}^{-2}$ @ TRIGA/JSI

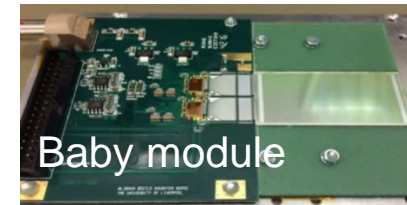


$$\text{MPV}_{\text{Irrad}} = 20150 \text{ e}^-$$

AC-coupled Strip-Sensors on 8" Wafers Beam-Test: Charge collection efficiency



- › Electron beam test conducted at DESY using a ALiBaVa Readout System



Irradiated sensor with neutrons $3.5 \cdot 10^{14} \text{ n}_{\text{eq}} \text{ cm}^{-2}$ @ TRIGA/JSI

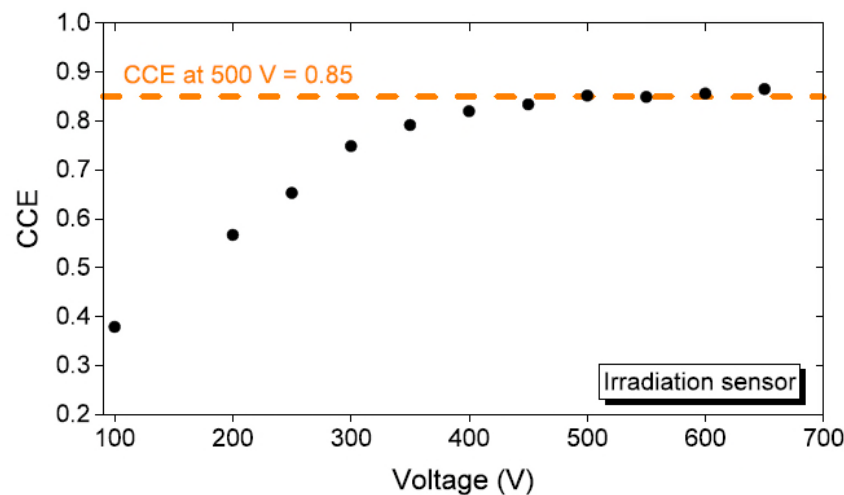
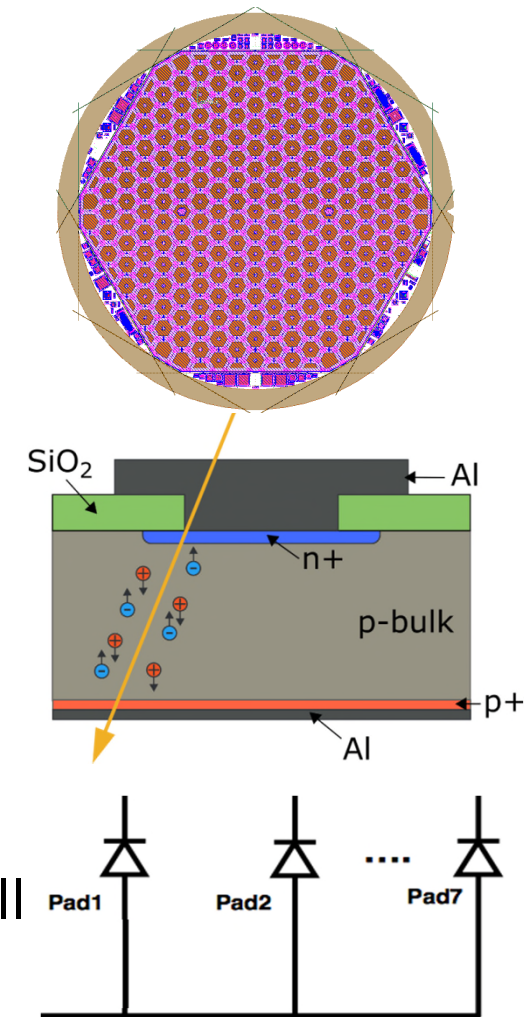
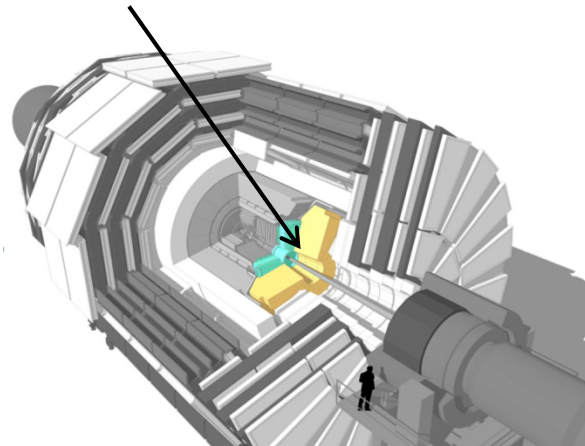


Figure 9.19.: Charge collection efficiency vs. bias voltage of the neutron irradiated sensor.

- › Summary Beam-Test-Results: Sensors perform very well

CMS High Granularity Calorimeter

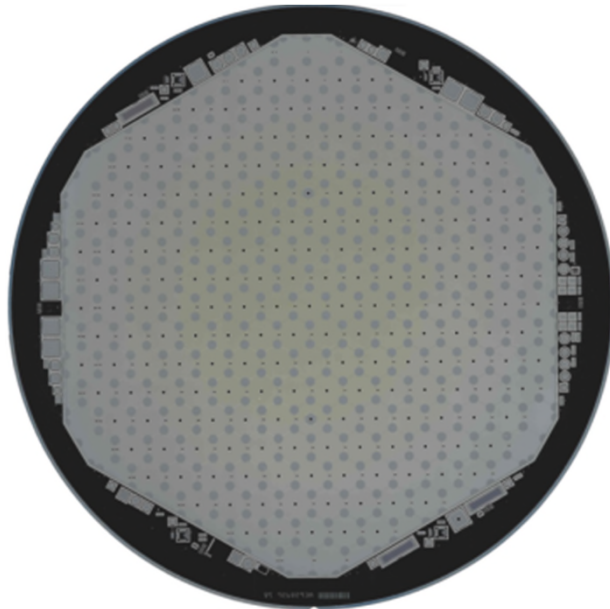
- › CMS will upgrade it's forward calorimeter
- › Si-sensors+Scintilators
- › 600 m² Si-sensors
- › 8" technology baseline
- › Active thicknesses
 - 300, 200, 120 um
- › 183 connected hexagonal diodes/pads
 - No common biasing (no bias ring)
 - Each pad is basically an individual diode
 - Biasing through the readout chip in module
 - For testing all pads have to be biased as well
 - This complicates sensor testing



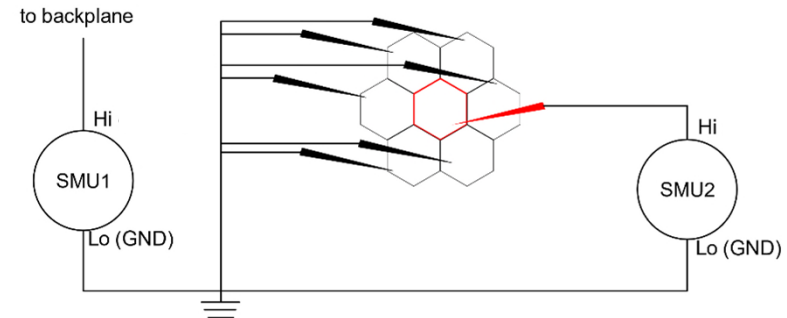
CMS High Granularity Calorimeter 8" planar n-in-p technology



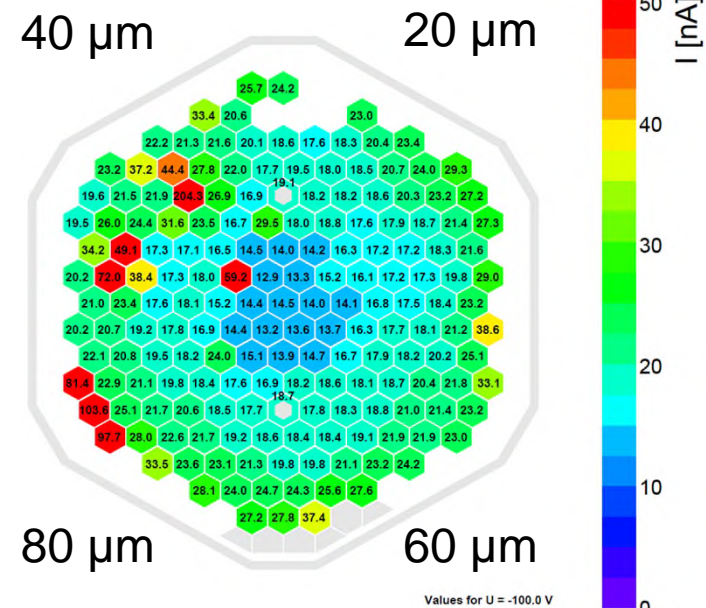
- World's first 8"-HGC-wafers were produced and characterized



- High voltage-stability needs to be improved
- New processing-concept is currently in processing



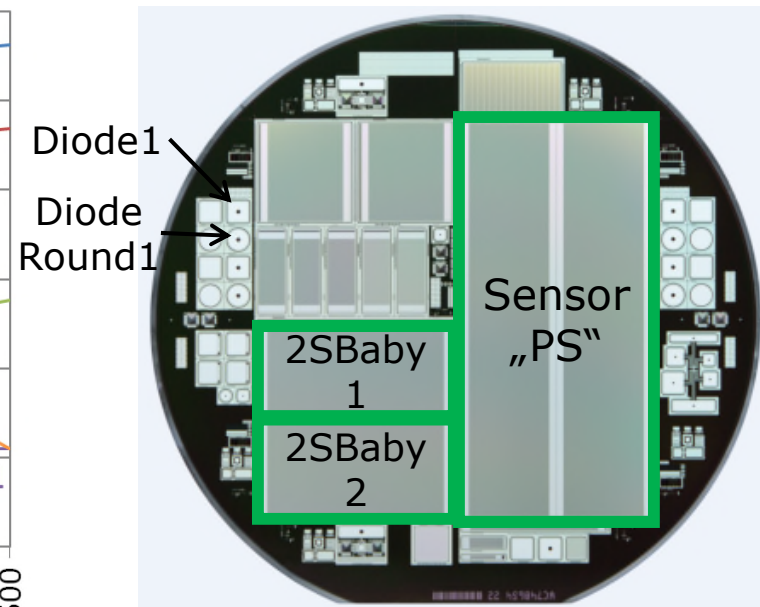
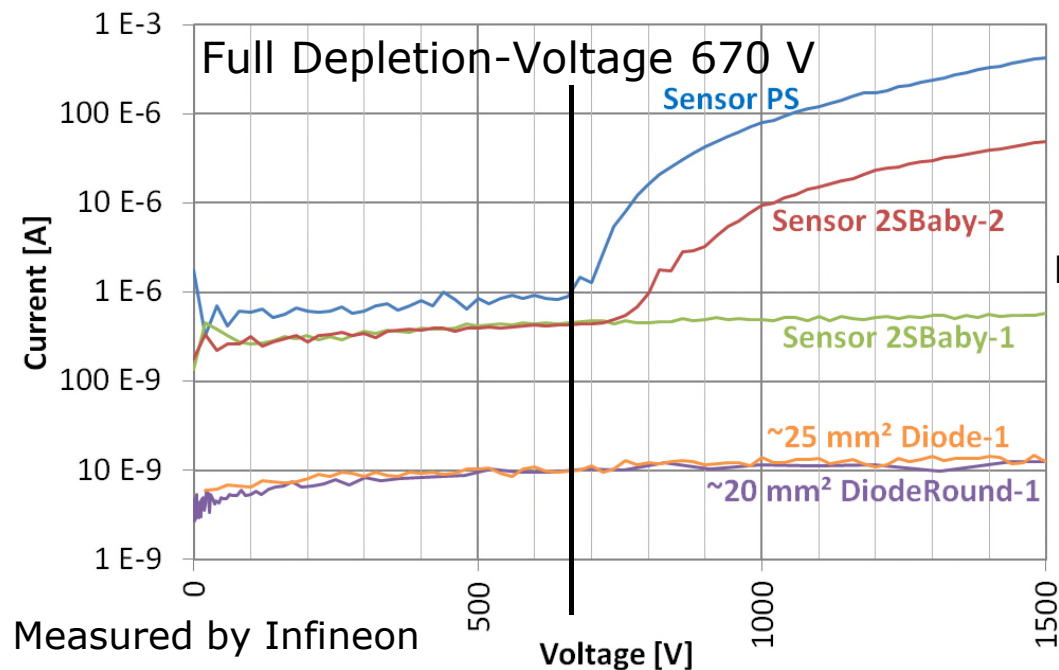
Current: 13 nA to 200+ nA (BD)



Current at -100 V IFX_8in_237_15

CMS-Tracker PS-Sensors 2017

- › New design with CMS-Tracker „PS“-Sensor 5 cm x 10 cm
- › 500 um active~physical thickness by intention for development



- › Smaller Sensor & Diodes stable up to more than 1500 V
- › Larger Sensors: HV-stability-improvement is ongoing

Summary and Conclusions

- › Processes for both 6" and 8" planar n-in-p strip & pad-sensors are created and characterized
- › Strip parameters are in spec
- › Radiation hardness is demonstrated
- › Beam-Test: very good performance
- › HV-stability needs to be improved
 - Infineon is working on solving this issue
- › Thanks for the work by HEPHY/Vienna

T. Bergauer, M. Dragicevic, A. König, E. Pree
V. Hinger, D. Blöch, M. Valentan

- › Thanks for your attention!



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